

April 2013

# FDPF3860T

# N-Channel PowerTrench<sup>®</sup> MOSFET 100 V, 20 A, 38.2 m $\Omega$

# **Description**

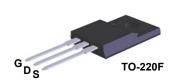
- R $_{\rm DS(on)}$  = 29.1 m $\Omega$  ( Typ ) @ V $_{\rm GS}$  = 10 V, I $_{\rm D}$  = 5.9 A
- · Fast Switching Speed
- · Low Gate Charge
- High Performance Trench Technology for Extremely Low  $R_{DS(\text{on})}$
- · High Power and Current Handling Capability
- · RoHS Compliant

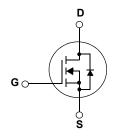
# **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor<sup>®</sup>'s advanced PowerTrench<sup>®</sup> process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

# **Applications**

- · Consumer Appliances
- LCD/LED/PDP TV
- · Synchronous Rectification
- · Uninterruptible Power Supply
- · Micro Solar Inverter





# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter			FDPF3860T	Unit
$V_{DSS}$	Drain to Source Voltage			100	V
$V_{GSS}$	Gate to Source Voltage			±20	V
	- Continuous (T <sub>C</sub> = 25°C)			20	^
ID	Drain Current	- Continuous (T <sub>C</sub> = 100°C)		12.7	A
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)		80	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energ	Single Pulsed Avalanche Energy (Note 2)		278	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)		20	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		(Note 1)	3.4	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	15	V/ns
Б	Davies Dissination	$(T_C = 25^{\circ}C)$		33.8	W
$P_{D}$	Power Dissipation	- Derate above 25°C		0.27	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Tempera	mperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

## **Thermal Characteristics**

Symbol	Parameter FDPF3		Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	3.7	°C/W
$R_{\theta,JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF3860T	FDPF3860T	TO-220F	-	-	50

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$ , $V_{GS} = 0 V$ , $T_J = 25 ^{\circ} C$	100	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.1	-	V/°C
1	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V	-	-	1	^
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 48V, T_{C} = 150^{\circ}C$	-	-	500	μА
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

## On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	-	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 5.9A$	-	29.1	38.2	mΩ
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_{D} = 5.9A$	ı	21	-	S

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V = 25V V = 0V	-	1350	1800	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1MHz	-	145	190	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 11911 12	-	60	90	pF

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	15	40	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 50V, I_{D} = 5.9A$	-	17	45	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10V, $R_{GEN}$ = $6\Omega$		24	60	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note	-	7	25	ns
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		-	23	35	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	$V_{DS} = 80V, I_{D} = 5.9A$	-	7	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	$V_{GS} = 10V$ (Note 4	-	8	-	nC

## **Drain-Source Diode Characteristics**

Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	20	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	80	Α
$V_{SD}$	Drain to Source Diode Forward Voltage V <sub>GS</sub> = 0V, I <sub>SD</sub> = 5.9A		-	-	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 5.9A	-	40	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	56	-	nC

#### Notes:

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L =16mH, I $_{AS}$  = 5.9A, V $_{DD}$  = 50V, R $_{G}$  = 25 $\Omega$ , Starting T $_{J}$  = 25°C
- 3. I  $_{SD}$   $\leq$  5.9A, di/dt  $\leq$  200A/ $\mu$ s,  $V_{DD}$   $\leq$  BV $_{DSS}$ , Starting T $_{J}$  = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

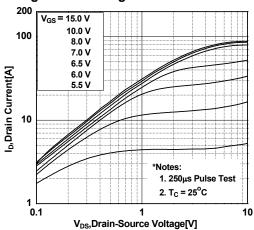


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

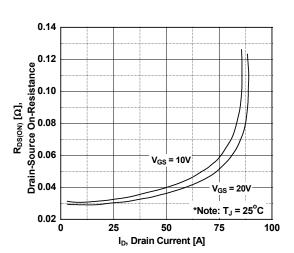


Figure 5. Capacitance Characteristics

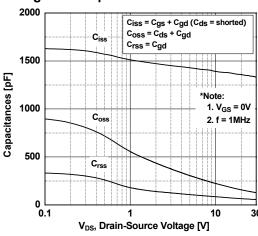


Figure 2. Transfer Characteristics

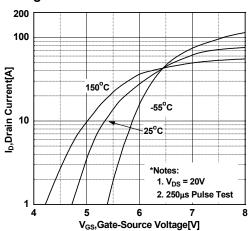


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

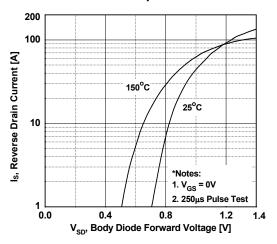
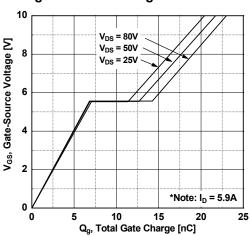


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

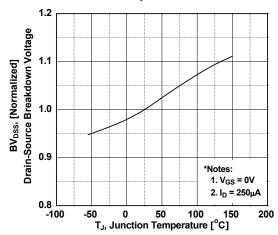


Figure 8. On-Resistance Variation vs. Temperature

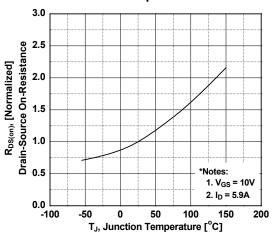


Figure 9. Maximum Safe Operating Area

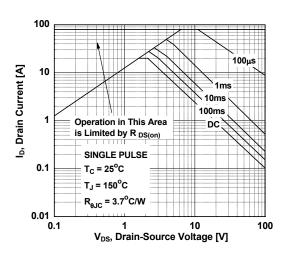


Figure 10. Maximum Drain Current vs. Case Temperature

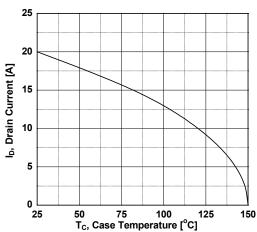
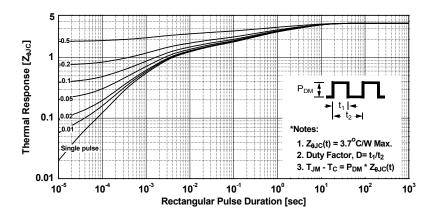
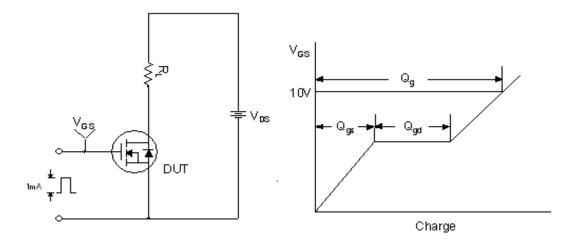


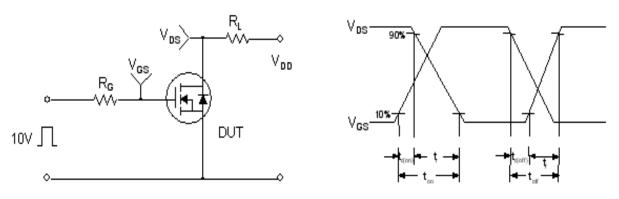
Figure 11. Transient Thermal Response Curve



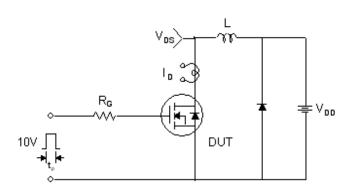
# **Gate Charge Test Circuit & Waveform**

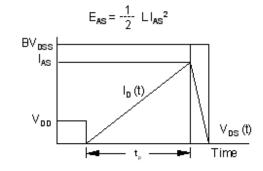


# **Resistive Switching Test Circuit & Waveforms**

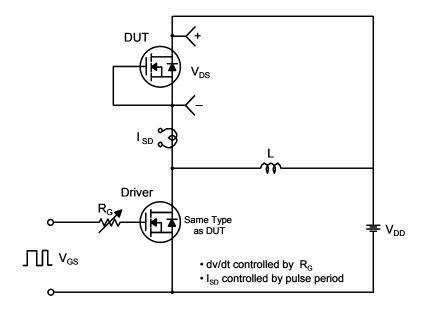


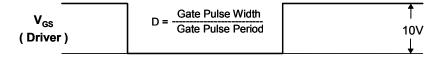
**Unclamped Inductive Switching Test Circuit & Waveforms** 

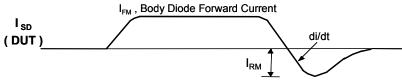




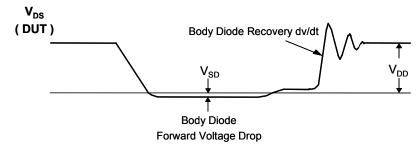
## Peak Diode Recovery dv/dt Test Circuit & Waveforms





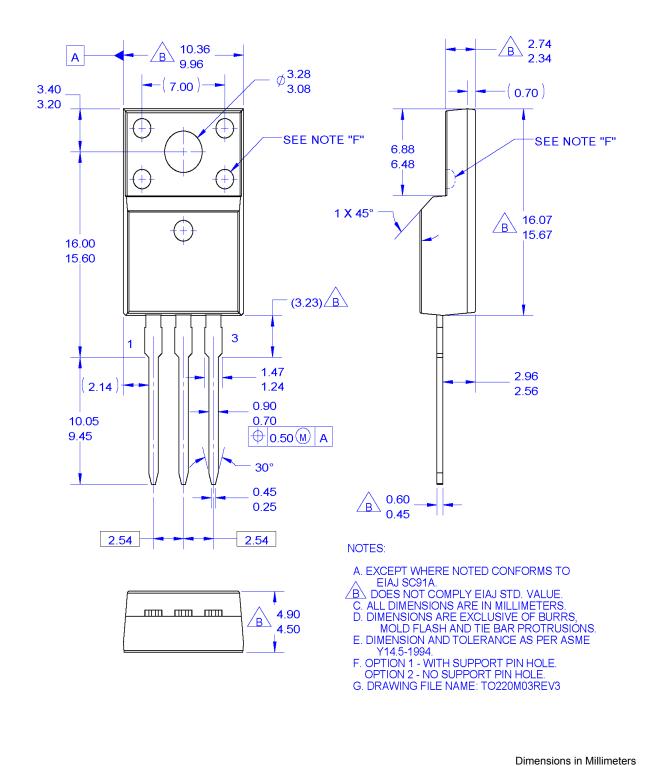


Body Diode Reverse Current



# **Mechanical Dimensions**

# TO-220M03







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